

Course Specifications

Valid as from the academic year 2025-2026

Processing and Packaging Technologies for Photonic Integration (E030450)

Course size	(nominal values; actual values)		Uyraiiiiie)		
Credits 4.0	Study time 1	20 h			
Course offerings in ac	ademic year 2025-2026				
A (semester 2)	English	Gent			
Lecturers in academic	: year 2025-2026				
Van Steenberge, Geert			TW06	W06 lecturer-in-charge	
Missinne, Jeroen			TW06	co-lecturer	
	ing programmes in 2025-2026			crdts	offerir
Master of Science in Silicon Photonics				4	A
Master of Science				4	А
Teaching languages					
English					
Keywords					
-	echnologies, packaging				
Position of the course					
	ents to various fabrication and pa	ockaning concents nec	occary for		
PICs					
Contents					
Introduction					
iSiPP50G Silicon	Photonics Platform				
Semiconductor T	echnologies				
Crystal Growth					
	al Growth from the Melt				
) Material				
The Czochralski T					
Distribution of D					
	-zone process				
	racterization				
Wafer S					
Crystal Character					
Silicon Oxidation					
	dation Process				
	distribution During Oxidation				
	perties of Silicon Dioxide				
Oxide Qualit	y Jess Characterization				
Photolithograph					
Optical Litho	an Room				
Exposure Tools					
Masks					
Photoresist					
Pattern Transfer					
Resolution					
	ation Lithography Methods				
	n Beam Lithography				
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Etching Wet Chemical Etching Silicon Etching Silicon Dioxide Etching Silicon Nitride Etching Aluminum Etching Drv Etching Plasma Fundamentals Etch Mechanism **Plasma Diagnostics End-Point Control** Reactive Plasma Etching Applications Diffusion **Basic Diffusion Process Diffusion Equation Diffusion Profiles** Extrinsic Diffusion Ion Implantation Range of Implanted Ions Ion Distribution Ion Stopping Ion Channeling Implant Damage and Annealing Film Deposition **Epitaxial Growth Techniques Chemical Vapor Deposition** Molecular Beam Epitaxy Structures and Defects in Epitaxial Layers Lattice-Matched and Strained-Layer Epitaxy Defects in Epitaxial Layers **Dielectric Deposition** Silicon Dioxide Silicon Nitride Metallization **Physical Vapor Deposition** Chemical Vapor Deposition **Aluminum Metallization Copper Metallization** Fabrication of Silicon Waveguide Devices Silicon-on-Insulator Separation by Implanted Oxygen (SIMOX) Bond and Etch-Back SOI Wafer Splitting Selected Components from iSiPP50G Silicon Photonics Platform Silicon Waveguides Modulators Photodiodes Grating couplers Packaging Technologies **Optical Packaging** Fiber-Coupling Grating-Coupling Edge-Coupling Fiber-Array Attach V-groove Integration Laser Integration Micro-Packaged Lasers Die Bonding Flip-Chip Bonding Transfer Printing Micro-Optics Integration **3D Nano-Printing** High-accuracy Pick-and-Place

Monolithic Micro-Optics Integration Electrical Packaging Wire Bonding Flip-Chip Bumping and Bonding Hybrid Bonding Wafer-Level Packaging 2D Integration Using Organic Interposers 2.5D Integration Using Silicon Interposers with TSVs 3D Integration Fanout Wafer-Level Packaging Micro-Chiplets Thermal Packaging Thermal Interface Materials Thermo-Electric Cooling

Initial competences

Basic optics and electromagnetics

Final competences

- 1 Understanding of different semiconductor process steps like crystal growth, oxidation, photolithography, etching, diffusion, ion implantation, and film deposition
- 2 Understanding of the fabrication of the most important integrated photonics components
- 3 Understanding of different photonics packaging processes like fiber array attach; laser integration, micro-optics integration, wire and flip-chip bonding, wafer-level packaging, thermal packaging.
- 4 Critical reading and understanding of a scientific article
- 5 Hands-on experience with a number of process steps in a clean room environment.
- 6 Development of a custom PIC package

Conditions for credit contract

Access to this course unit via a credit contract is determined after successful competences assessment

Conditions for exam contract

This course unit cannot be taken via an exam contract

Teaching methods

Lecture, Practical, Independent work

Extra information on the teaching methods

Lectures, cleanroom project, independent work

Study material

Type: Slides

Name: Slides and course notes used during the course Indicative price: Free or paid by faculty Optional: no Additional information: Available electronically (free)

References

[1] May, Gary S.; Sze, Simon M. Fundamentals of Semiconductor Fabrication, John Wiley and Sons, 2004.

[2] C.Y. Chang and S.M. Sze. ULSI Technology, McGraw-Hill, 1996.

[3] C.Y. Chang and S.M. Sze. ULSI Devices, John Wiley and Sons, 2000.

[4] S.M. Sze. VLSI Technology, McGraw-Hill, 1988.

[5] H. Zimmermann. Silicon Optoelectronic Integrated Circuits, Springer, 2004.

Course content-related study coaching

4 researchers

Assessment moments

end-of-term and continuous assessment

Examination methods in case of periodic assessment during the first examination period

Oral assessment

Examination methods in case of periodic assessment during the second examination period

Oral assessment

Examination methods in case of permanent assessment

Oral assessment

Possibilities of retake in case of permanent assessment

examination during the second examination period is possible in modified form

Extra information on the examination methods

- During examination period: oral closed-book assessment.
- During semester: periodic and permanent evaluation. Presentation about a project focusing on fabrication and packaging

Calculation of the examination mark

70% oral exam, 30% presentation.